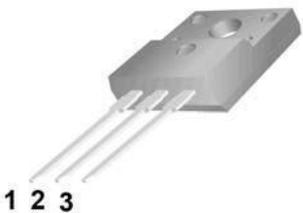
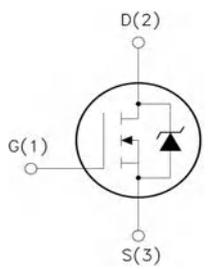


<p><b>28N50</b> 500V N-Channel MOSFET</p> <p><b>Features:</b></p> <ul style="list-style-type: none"> <li><input type="checkbox"/> Low Intrinsic Capacitances.</li> <li><input type="checkbox"/> Excellent Switching Characteristics.</li> <li><input type="checkbox"/> Extended Safe Operating Area.</li> <li><input type="checkbox"/> Unrivalled Gate Charge :<math>Q_g=78\text{ nC}</math> (Typ.).</li> <li><input type="checkbox"/> <math>V_{DSS}=500\text{V}, I_D=30\text{A}</math></li> <li><input type="checkbox"/> <math>R_{DS(on)} : 160\text{m}\Omega</math> (Tye) @<math>V_G=10\text{V}</math></li> <li><input type="checkbox"/> 100% Avalanche Tested</li> </ul>	<div style="text-align: right;">  </div> <p style="text-align: center;"><b>TO-220F</b></p>   <div style="margin-left: 20px;"> <p>1.Gate (G)</p> <p>2.Drain (D)</p> <p>3.Source (S)</p> </div>
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### Absolute Maximum Ratings (\* Drain current limited by junction temperature)

Symbol	Parameter	28N50	Unit
$V_{DSS}$	Drain-to-Source Voltage	500	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 30$	
$I_D$	Continuous Drain Current	30	A
	Continuous Drain Current @ $T_c=100^\circ\text{C}$	18	
$I_{DM}$	Pulsed Drain Current at $V_{GS}=10\text{V}^{[2,4]}$	112	
$E_{AS}$	Single Pulse Avalanche Energy	3000	mJ
$dv/dt$	Peak Diode Recovery $dv/dt^{[3]}$	5.0	V/ns
$P_D$	Power Dissipation	300	W
	Derating Factor above $25^\circ\text{C}$	2.38	W/ $^\circ\text{C}$
$T_L$ $T_{PAK}$	Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	300 260	$^\circ\text{C}$
$T_J \& T_{STG}$	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

### Thermal Characteristics

Symbol	Parameter	28N50	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.42	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	55	

**Electrical Characteristics** (  $T_C = 25\text{ }^\circ\text{C}$  unless otherwise noted )

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	500	-	-	V
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temperature coefficient	$I_D = 250\mu A$ , referenced to $25\text{ }^\circ\text{C}$	-	0.3	-	V/ $^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	1	$\mu A$
		$V_{DS} = 400V, T_C = 125\text{ }^\circ\text{C}$	-	-	10	$\mu A$
$I_{GSS}$	Gate-Source Leakage, Forward	$V_{GS} = 30V, V_{DS} = 0V$	-	-	100	nA
	Gate-source Leakage, Reverse	$V_{GS} = -30V, V_{DS} = 0V$	-	-	-100	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	-	4.0	V
$R_{DS(ON)}$	Static Drain-Source On-state Resistance	$V_{GS} = 10V, I_D = 15A$	-	160	200	m $\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$	-	4500	-	pF
$C_{oss}$	Output Capacitance		-	3150	-	
$C_{rss}$	Reverse Transfer Capacitance		-	450	-	
<b>Dynamic Characteristics</b>						
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = 250V, I_D = 15.0A, R_G = 25\Omega$ (Note 4, 5)	-	25	-	ns
$t_r$	Rise Time		-	39	-	
$t_{d(off)}$	Turn-off Delay Time		-	100	-	
$t_f$	Fall Time		-	36	-	
$Q_g$	Total Gate Charge	$V_{DS} = 250V, V_{GS} = 10V, I_D = 30.0A$ (Note 4, 5)	-	78	-	nC
$Q_{gs}$	Gate-Source Charge		-	21	-	
$Q_{gd}$	Gate-Drain Charge(Miller Charge)		-	20	-	

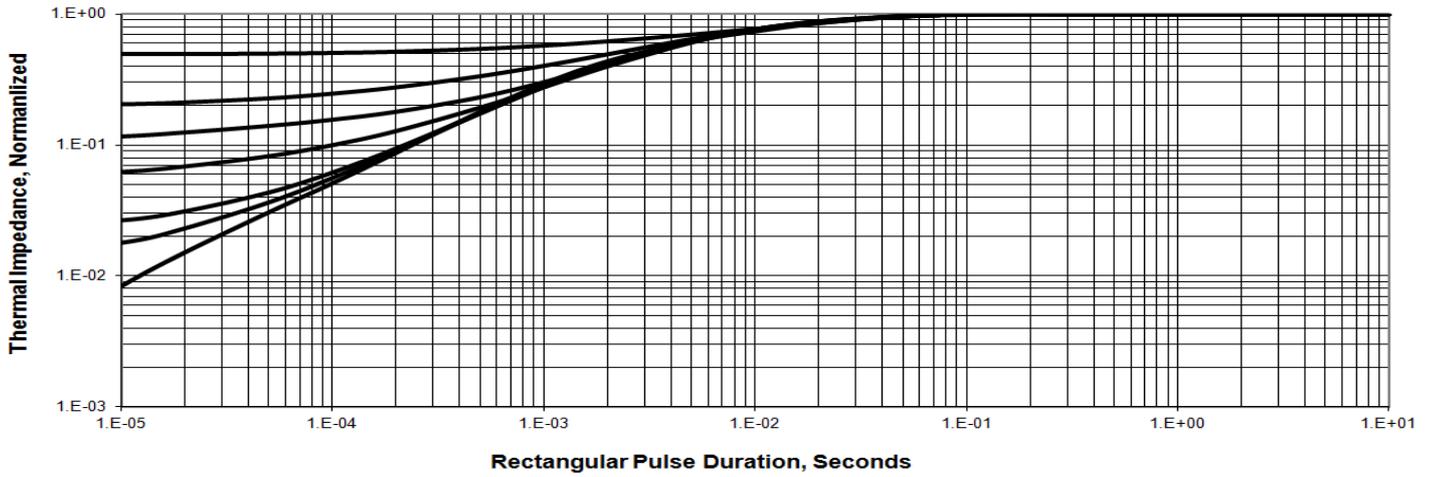
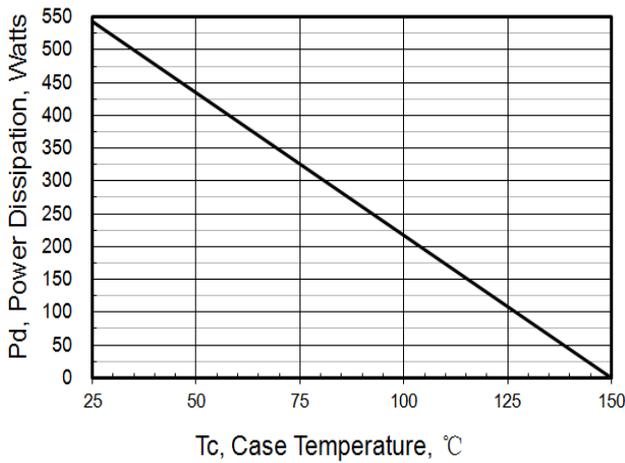
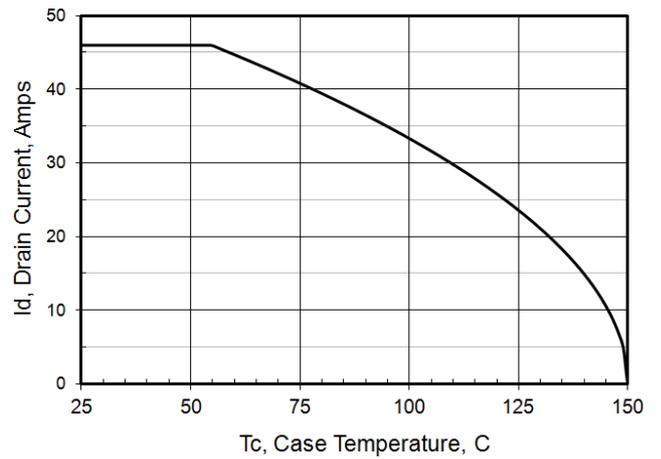
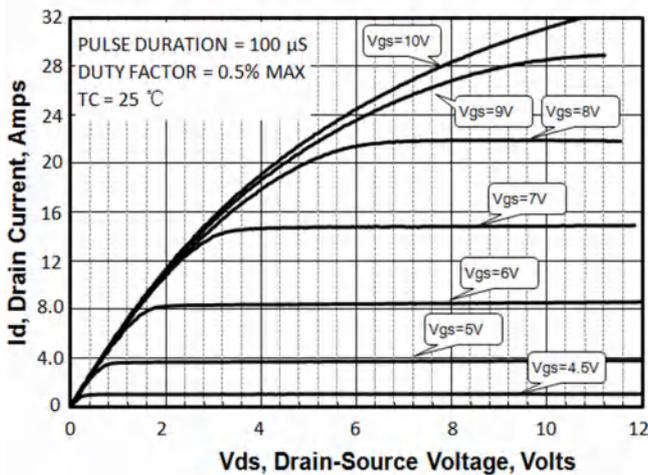
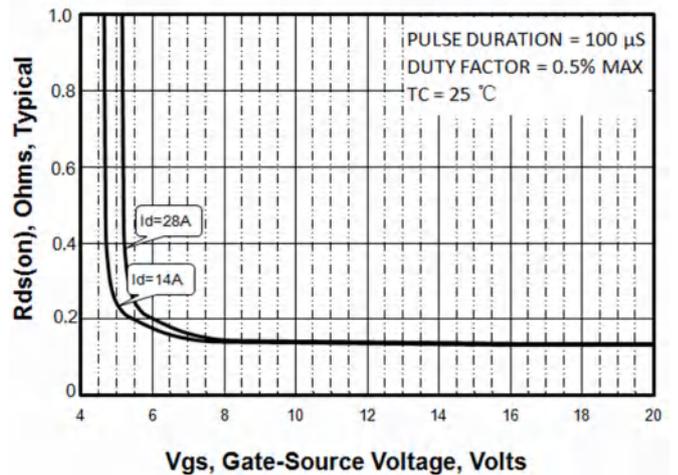
**Source-Drain Diode Ratings and Characteristics**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit.
$I_S$	Continuous Source Current	Integral Reverse p-n Junction Diode in the MOSFET	-	-	30	A
$I_{SM}$	Pulsed Source Current		-	-	110	
$V_{SD}$	Diode Forward Voltage	$I_S = 30.0A, V_{GS} = 0V$	-	-	1.4	V
$t_{rr}$	Reverse Recovery Time	$I_S = 30A, V_{GS} = 0V, dI_F/dt = 100A/\mu s$	-	530	-	ns
$Q_{rr}$	Reverse Recovery Charge		-	4.6	-	$\mu C$

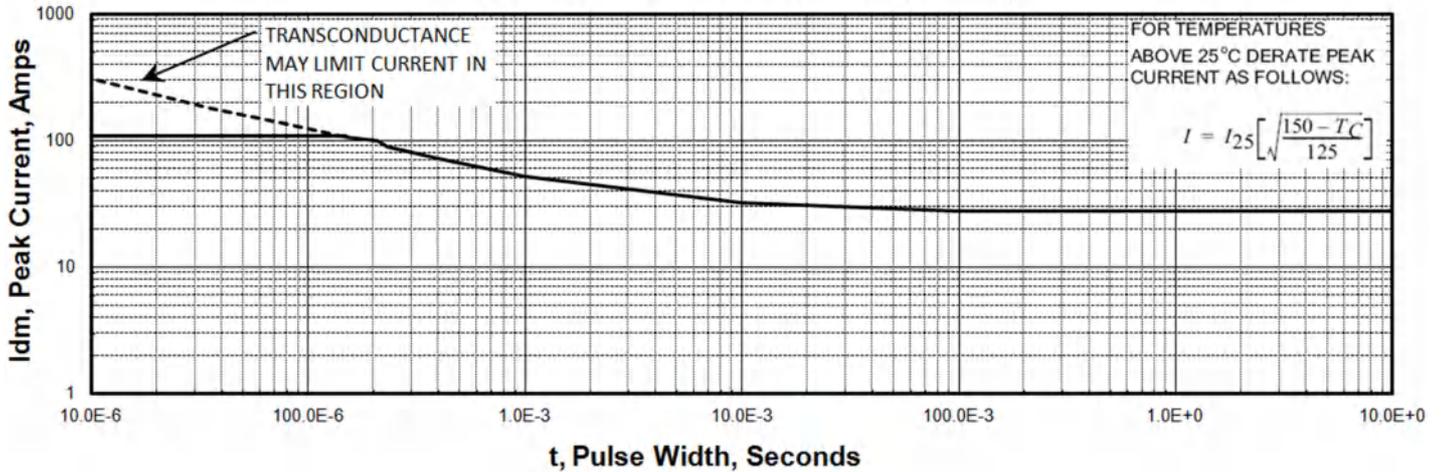
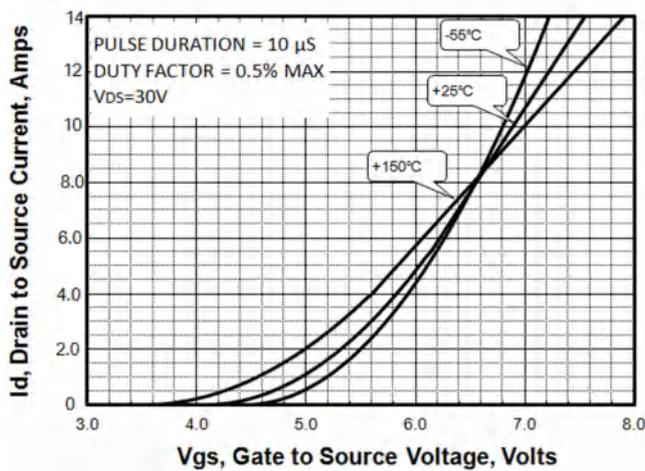
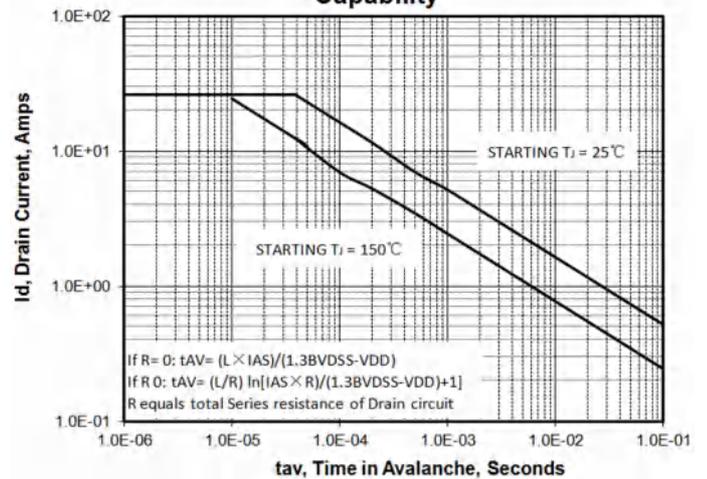
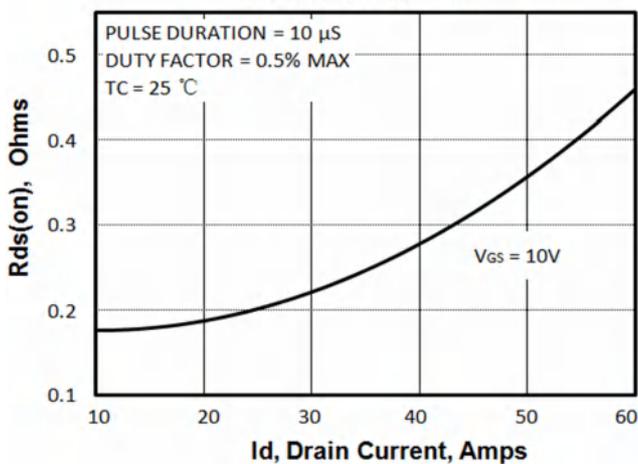
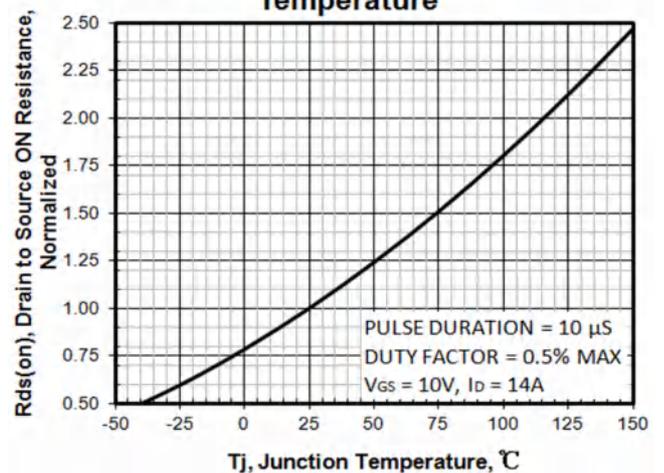
**\* NOTES**

- [1]  $T_J = +25\text{ }^\circ\text{C}$  to  $+150\text{ }^\circ\text{C}$  .  
 [2] Silicon limited current only.  
 [3] Package limited current.  
 [4] Repetitive rating; pulse width limited by maximum junction temperature.  
 [5] Pulse width  $\leq 380\mu s$ ; duty cycle  $\leq 2\%$ .

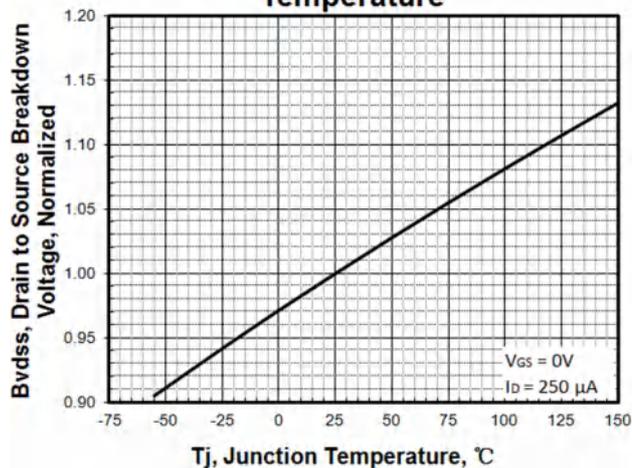
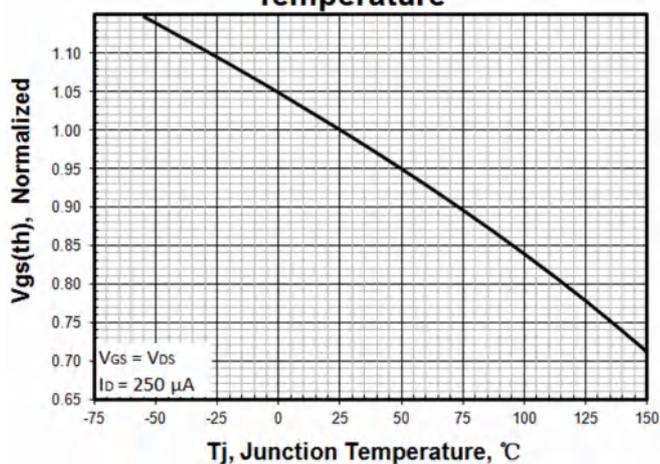
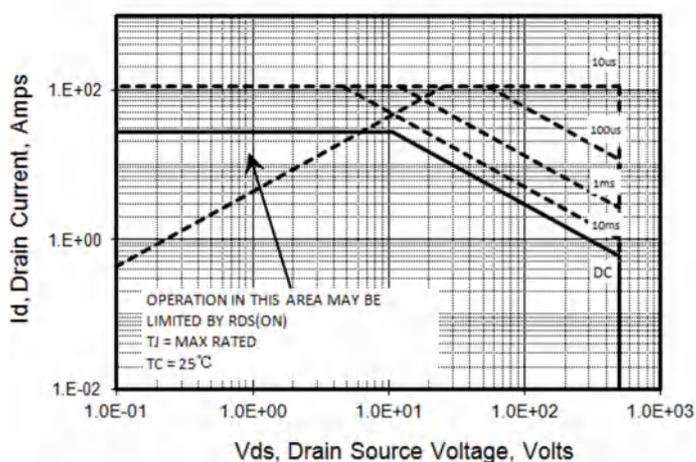
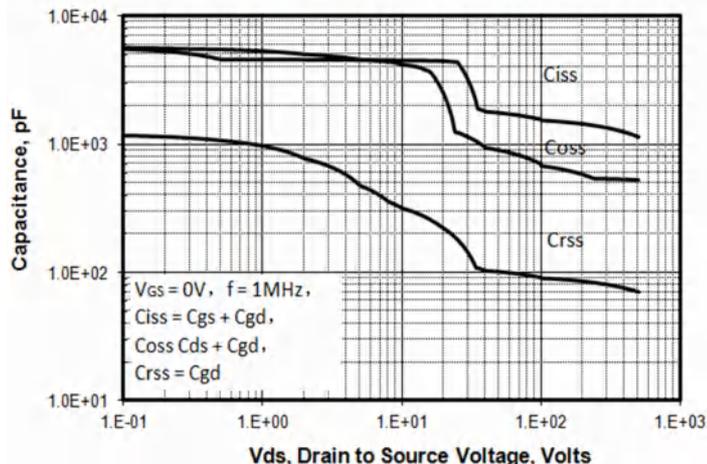
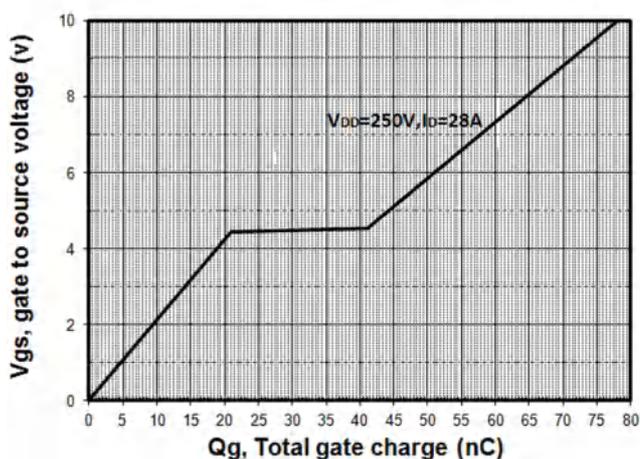
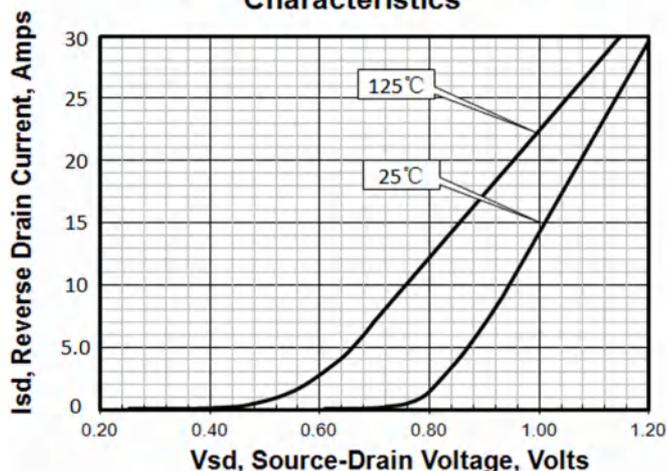
**Typical Characteristics** (  $T_C = 25\text{ }^\circ\text{C}$  unless otherwise noted )

**Figure 1. Maximum Transient Thermal Impedance**

**Figure 2 . Max. Power Dissipation vs Case Temperature**

**Figure 3 .Maximum Continuous Drain Current vs Tc**

**Figure 4. Output Characteristics**

**Figure 5. Rds(on) vs Gate Voltage**


**Typical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

**Figure 6. Peak Current Capability**

**Figure 7. Transfer Characteristics**

**Figure 8. Unclamped Inductive Switching Capability**

**Figure 9. Drain to Source ON Resistance vs Drain Current**

**Figure 10. Rds(on) vs Junction Temperature**


**Typical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

**Figure 11. Breakdown Voltage vs Temperature**

**Figure 12. Threshold Voltage vs Temperature**

**Figure 13. Maximum Safe Operating Area**

**Figure 14. Capacitance vs Vds**

**Figure 15. Typical Gate Charge**

**Figure 16. Body Diode Transfer Characteristics**


Test circuit

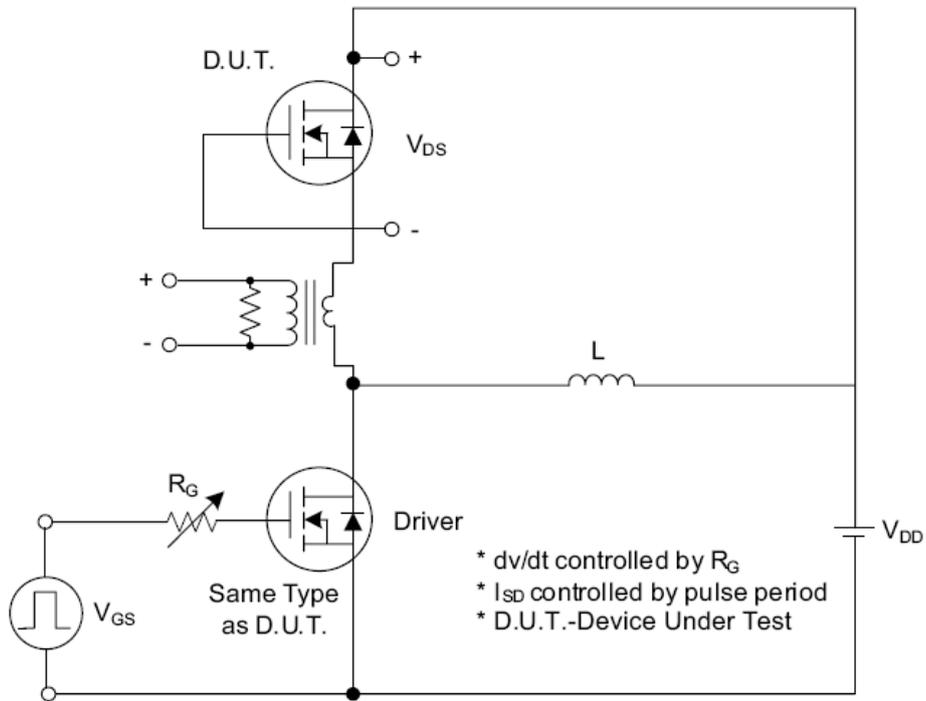


Fig. 1.1 Peak Diode Recovery  $dv/dt$  Test Circuit

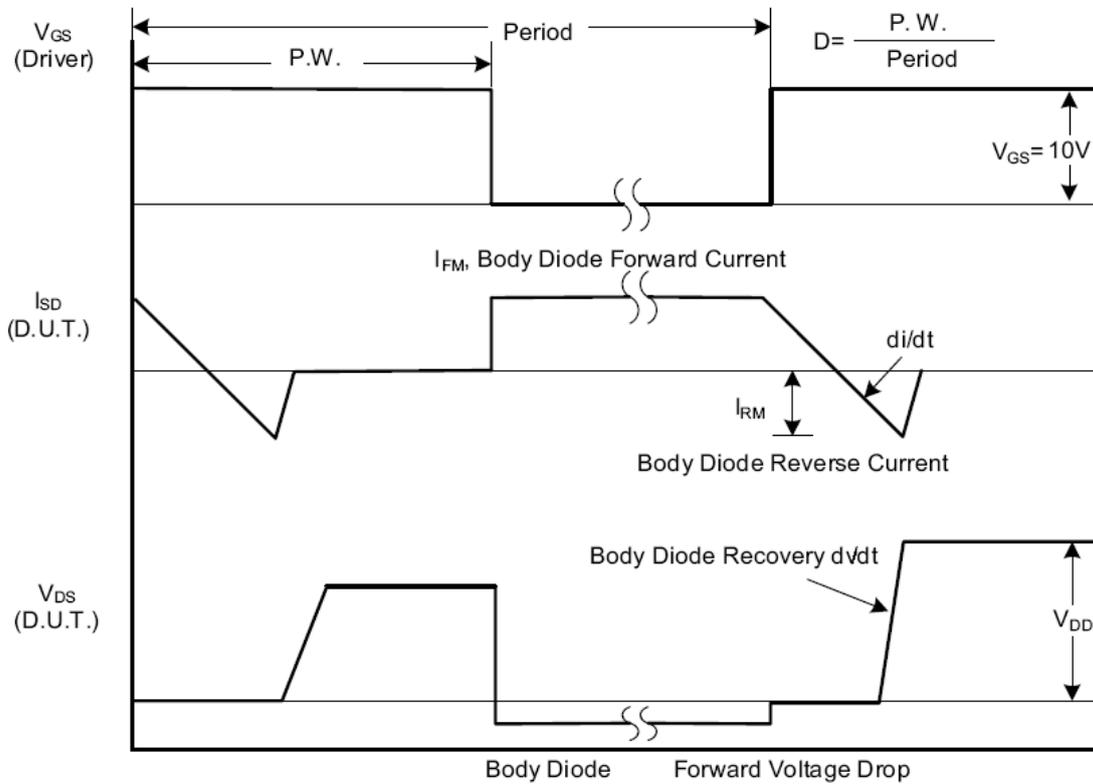


Fig. 1.2 Peak Diode Recovery  $dv/dt$  Waveforms

**Test circuit**

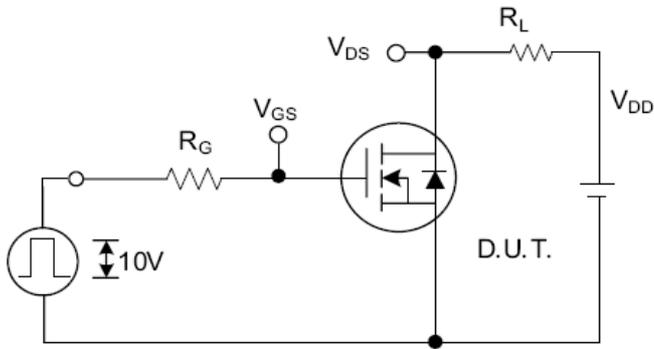


Fig. 2.1 Switching Test Circuit

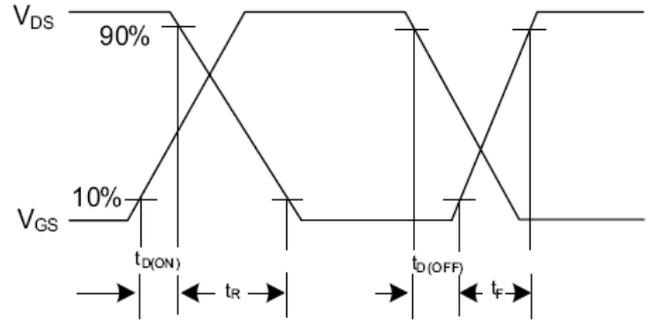


Fig. 2.2 Switching Waveforms

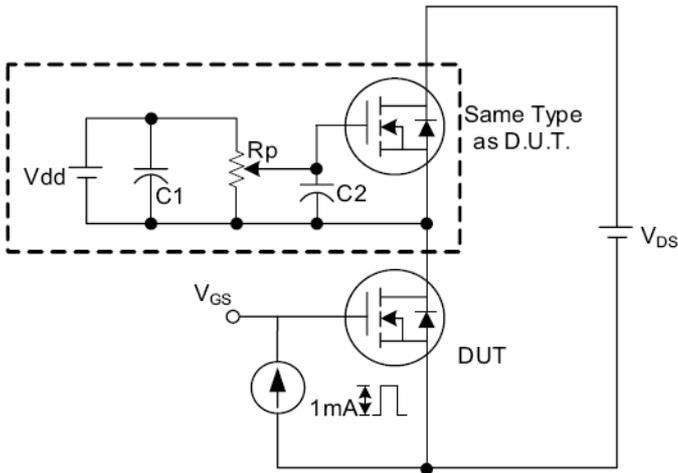


Fig. 3.1 Gate Charge Test Circuit

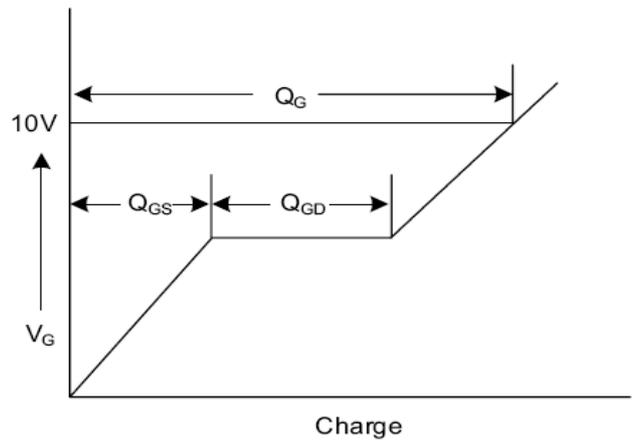


Fig. 3.2 Gate Charge Waveform

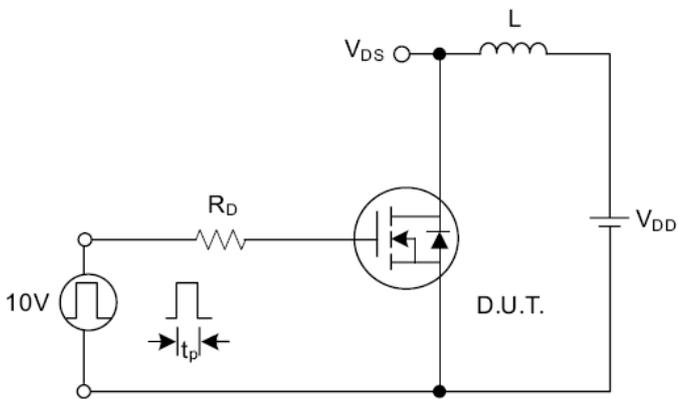


Fig. 4.1 Unclamped Inductive Switching Test Circuit

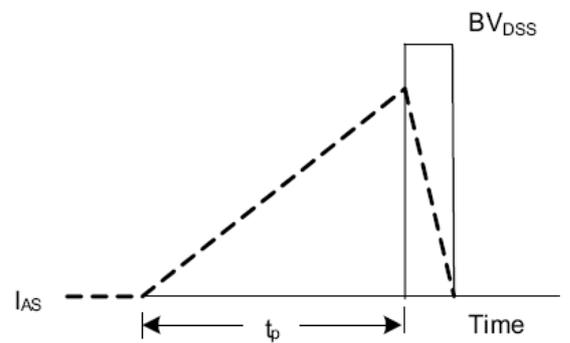
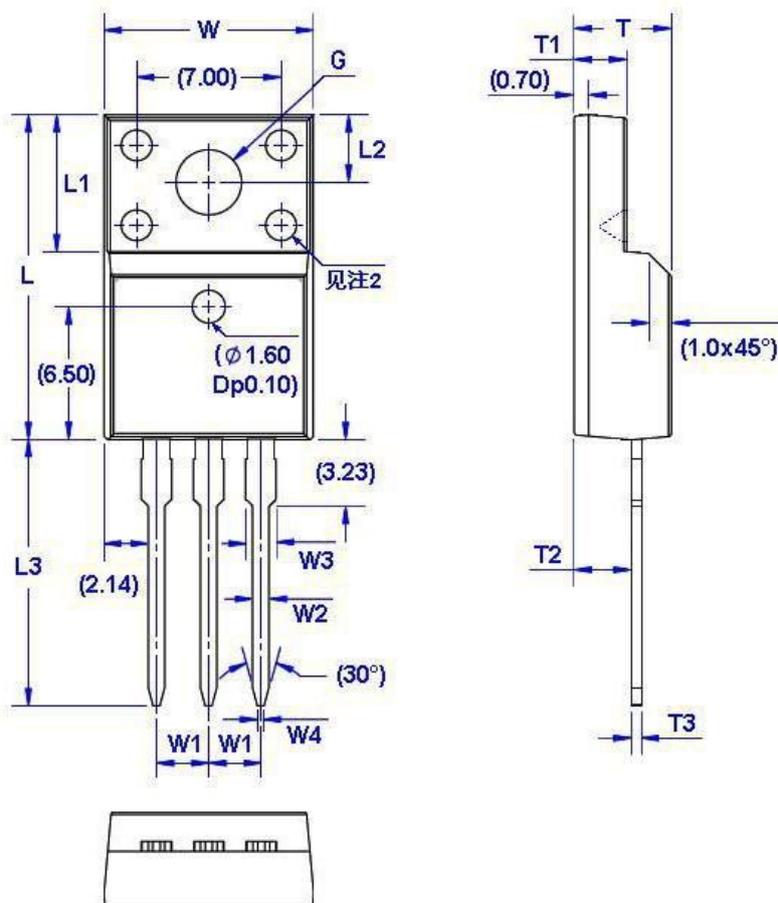


Fig. 4.2 Unclamped Inductive Switching Waveforms

## Package Dimension

TO-220F

Unit: mm



Symbol	Size		Symbol	Size		Symbol	Size		Symbol	Size	
	Min	Max		Min	Max		Min	Max		Min	Max
W	9.96	10.36	W4	0.25	0.45	L3	12.78	13.18	T3	0.45	0.60
W1	2.54 (TYP)		L	15.67	16.07	T	4.50	4.90	G(Φ)	3.08	3.28
W2	0.70	0.90	L1	6.48	6.88	T1	2.34	2.74			
W3	1.24	1.47	L2	3.20	3.40	T2	2.56	2.96			